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Designer's™ Data Sheet TMOS E-FET ™ **High Energy Power FET** N-Channel Enhancement-Mode Silicon Gate

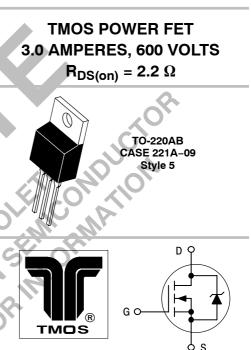
This advanced high voltage TMOS E-FET is designed to withstand high energy in the avalanche mode and switch efficiently. This new high energy device also offers a drain-to-source diode with fast recovery time. Designed for high voltage, high speed switching applications such as power supplies, PWM motor controls and other inductive loads, the avalanche energy capability is specified to eliminate the guesswork in designs where inductive loads are switched and offer additional safety margin against unexpected voltage transients.

- Avalanche Energy Capability Specified at Elevated Temperature
- Low Stored Gate Charge for Efficient Switching
- • Internal Source-to-Drain Diode Designed to Replace External Zener Transient Suppressor — Absorbs High Energy in the Avalanche Mode
- Source-to-Drain Diode Recovery Time Comparable to Discrete Fast Recovery Diode



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Preferred devices are Motorola recommended choices for future use and best overall value.

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit |
|--|---|------------------|---------------|
| Drain-Source Voltage | V _{DSS} | 600 | Vdc |
| Drain–Gate Voltage (R_{GS} = 1.0 M Ω) | V _{DGR} | 600 | Vdc |
| Gate-Source Voltage — Continuous — Non-repetitive | V _{GS} V _{GSM} | ±20 ±40 | Vdc Vpk |
| Drain Current — Continuous — Continuous @ 100°C — Pulsed | I _D I _D I _{DM} | 3.0 2.4 14 | Adc |
| Total Power Dissipation @ T _C = 25°C Derate above 25°C | P _D | 75 0.6 | Watts W/°C |
| Operating and Storage Temperature Range | T _J , T _{stg} | -55 to 150 | °C |

UNCLAMPED DRAIN-TO-SOURCE AVALANCHE CHARACTERISTICS (T $_{\rm J}$ < 150°C)

| Single Pulse Drain-to-Source Avalanche Energy — T _J = 25°C — T ₁ = 100°C | W _{DSR(1)} | 290 46 | mJ |
|---|---------------------|-----------|----|
| Repetitive Pulse Drain-to-Source Avalanche Energy | W _{DSR(2)} | 7.5 | |
| | | | |

THERMAL CHARACTERISTICS

| Thermal Resistance — Junction to Case — Junction to Ambient | $\begin{array}{c c} R_{\theta JC} & 1.67 \\ R_{\theta JA} & 62.5 \end{array}$ | °C/W |
|--|---|------|
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | Т 260 | °C |

(1) V_{DD} = 50 V, I_D = 3.0 A

(2) Pulse Width and frequency is limited by T_J(max) and thermal response

Designer's Data for "Worst Case" Conditions - The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

| Characteristic | Symbol | Min | Тур | Max | Unit |
|--|----------------------|-----|-----|-----------|------|
| OFF CHARACTERISTICS | | | | | |
| Drain-to-Source Breakdown Voltage ($V_{GS} = 0$, $I_D = 250 \ \mu Adc$) | V _{(BR)DSS} | 600 | _ | _ | Vdc |
| Zero Gate Voltage Drain Current ($V_{DS} = 600 \text{ V}, V_{GS} = 0$) ($V_{DS} = 480 \text{ V}, V_{GS} = 0, T_J = 125^{\circ}\text{C}$) | I _{DSS} | | | 10 100 | μAdc |
| Gate-Body Leakage Current — Forward (V_{GSF} = 20 Vdc, V_{DS} = 0) | I _{GSSF} | — | _ | 100 | nAdc |
| Gate-Body Leakage Current — Reverse (V _{GSR} = 20 Vdc, V _{DS} = 0) | I _{GSSR} | — | — | 100 | nAdc |

ON CHARACTERISTICS*

| Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 250 \ \mu Adc)$ $(T_J = 125^{\circ}C)$ | V _{GS(th)} | 2.0 1.5 | | 4.0 3.5 | Vdc |
|---|---------------------|------------|---|------------|------|
| Static Drain-to-Source On-Resistance (V_{GS} = 10 Vdc, I_D = 1.5 A) | R _{DS(on)} | — | 2.1 | 2.2 | Ohms |
| $ Drain-to-Source On-Voltage (V_{GS} = 10 Vdc) \\ (I_D = 3.0 A) \\ (I_D = 1.5 A, T_J = 100^{\circ}C) $ | V _{DS(on)} | | Z | 9.0 7.5 | Vdc |
| Forward Transconductance (V _{DS} = 15 Vdc, I _D = 1.5 A) | 9FS | 1.5 | S= . | — | mhos |
| DYNAMIC CHARACTERISTICS | | | ~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~ | | |

DYNAMIC CHARACTERISTICS

| Input Capacitance | | C _{iss} | 770 | — | pF |
|----------------------------|---|--------------------|-----|---|----|
| Output Capacitance | (V _{DS} = 25 V, V _{GS} = 0, f = 1.0 MHz) | C _{oss} — | 105 | — | |
| Transfer Capacitance | | C _{rss} – | 19 | — | |
| SWITCHING CHARACTERISTICS* | | | | | |

SWITCHING CHARACTERISTICS*

| Turn-On Delay Time | 5 | t _{d(on)} | I | 23 | _ | ns |
|---------------------|---|---------------------|---|-----|----|----|
| Rise Time | $(V_{DD} = 300 \text{ V}, I_D \approx 3.0 \text{ A},$ By $= 100 \text{ O}, B_{D} = 12 \text{ O}$ | tr | _ | 34 | _ | |
| Turn-Off Delay Time | | t _{d(off)} | _ | 58 | _ | |
| Fall Time | | t _f | _ | 35 | _ | |
| Total Gate Charge | | Qg | | 28 | 31 | nC |
| Gate-Source Charge | $(V_{DS} = 420 \text{ V}, I_D = 3.0 \text{ A}, V_{GS} = 10 \text{ V})$ | Q _{gs} | _ | 5.0 | _ | |
| Gate-Drain Charge | | Q _{gd} | | 17 | | |

SOURCE-DRAIN DIODE CHARACTERISTICS

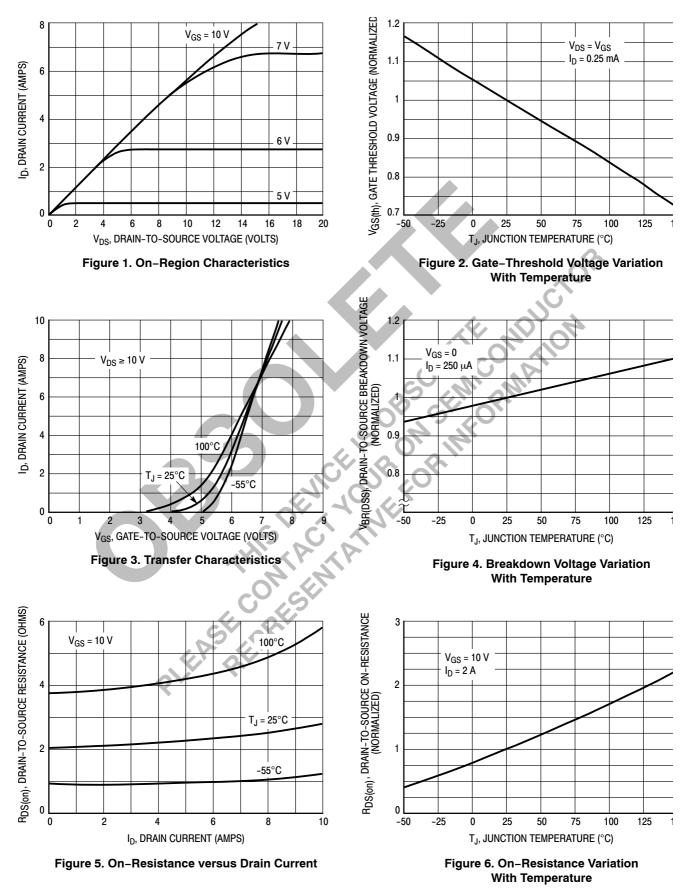
| Forward On-Voltage | CO. CK. | V _{SD} | _ | _ | 1.4 | Vdc |
|----------------------------|--|-----------------|---|-----|-----|-----|
| Forward Turn-On Time | (I _S = 3.0 A, di/dt = 100 A/µs) | t _{on} | _ | ** | | ns |
| Reverse Recovery Time | SV of | t _{rr} | | 400 | | |
| INTERNAL PACKAGE INDUCTANC | E | | | | | |

nΗ Internal Drain Inductance L_{d} (Measured from the contact screw on tab to center of die) 3.5 (Measured from the drain lead 0.25" from package to center of die) 4.5 ____ ____ 7.5 Internal Source Inductance L_{s} _____ ____ (Measured from the source lead 0.25" from package to source bond pad)

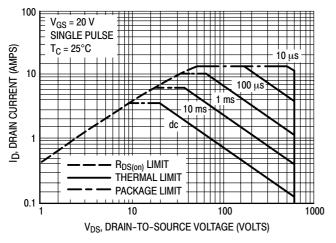
*Pulse Test: Pulse Width = 300 μ s, Duty Cycle \leq 2.0%.

** Limited by circuit inductance.

TYPICAL ELECTRICAL CHARACTERISTICS



SAFE OPERATING AREA INFORMATION



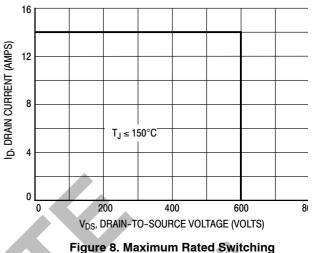


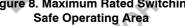
FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.





The power averaged over a complete switching cycle must be less than:

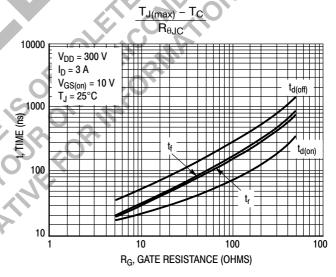
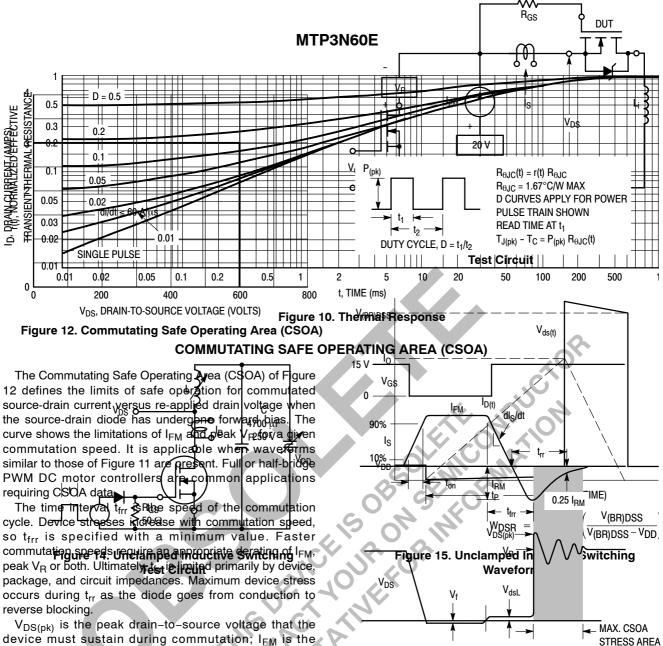


Figure 9. Resistive Switching Time Variation versus Gate Resistance



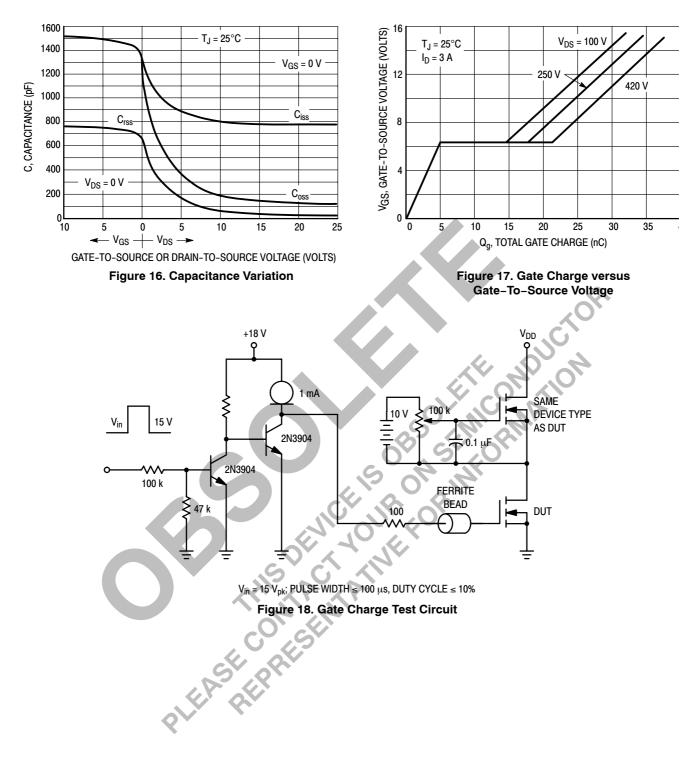
device must sustain during commutation; I_{FM} is the maximum forward source-drain diode current just prior to the onset of commutation.

 V_R is specified at 80% of $V_{(BR)DSS}$ to ensure that the CSOA stress is maximized as I_S decays from I_{RM} to zero.

 R_{GS} should be minimized during commutation. $T_{\rm J}$ has only a second order effect on CSOA.

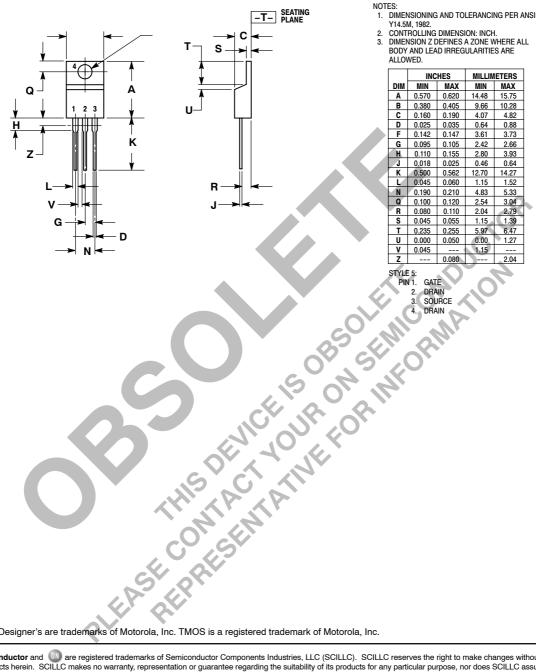
Stray inductances, $L_{\rm i}$ in Motorola's test circuit are assumed to be practical minimums.

Figure 11. Commutating Waveforms



PACKAGE DIMENSIONS

CASE 221A-09 **ISSUE Z**



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